# NGD8205AN - 20 A, 350 V, N-Channel Ignition IGBT, DPAK



20 Amps, 350 Volts  $V_{CE}(on) \le 1.3 V @$  $I_{C} = 10 \text{ A}, V_{GE} \ge 4.5 \text{ V}$ 

#### **Maximum Ratings** (T<sub>1</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V <sub>ces</sub>	390	V <sub>DC</sub>
Gate-Gate Voltage	V <sub>cer</sub>	390	V <sub>DC</sub>
Gate-Emitter Voltage	V <sub>ge</sub>	±15	V <sub>DC</sub>
Collector Current-Continuous @T <sub>c</sub> = 25°C - Pulsed	I <sub>c</sub>	20 50	A <sub>DC</sub> A <sub>AC</sub>
Continuous Gate Current	Ι <sub>G</sub>	1.0	mA
ESD (Charged–Device Model)	ESD	2.0	kV
ESD (Human Body Model) R = 1500 $\Omega,$ C = 100 pF	ESD	8.0	kV
ESD (Machine Model) R = 0 $\Omega$ , C = 200 pF	ESD	400	V
Total Power Dissipation @T <sub>c</sub> = 25°C Derate above 25°C	P <sub>D</sub>	125 0.83	W W/°C
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

## Description

This Logic Level Insulated Gate Bipolar Transistor (IGBT) features monolithic circuitry integrating ESD and Over– Voltage clamped protection for use in inductive coil drivers applications. Primary uses include Ignition, Direct Fuel Injection, or wherever high voltage and high current switching is required.

Po

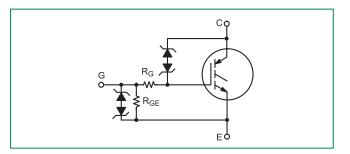
## Features

- Ideal for Coil-on-Plug and Driver-on-Coil Applications
- DPAK Package Offers Smaller Footprint for Increased Board Space
- Gate-Emitter ESD Protection
- Temperature Compensated Gate-Collector Voltage Clamp Limits Stress Applied to Load
- Integrated ESD Diode Protection
- Low Threshold Voltage for Interfacing Power Loads to Logic or Microprocessor Devices
- Low Saturation Voltage
- High Pulsed Current Capability
- Optional Gate Resistor (R $_{\rm G})$  and Gate–Emitter Resistor (R $_{\rm GF})$
- These are Pb-Free Devices

## Applications

• Ignition Systems

## **Functional Diagram**



## Additional Information





## Unclamped Collector–To–Emitter Avalanche Characteristics (–55° $\leq$ T<sub>J</sub> $\leq$ 175°C)

	Symbol	Value	Unit
Single Pulse Collector-to-Emitter Avalanche Energy			
$V_{_{CC}}$ = 50 V, $V_{_{GE}}$ = 5.0 V, $P_{_{R}} I_{_{L}}$ = 16.7 A, $R_{_{G}}$ = 1000 $\Omega$ , L = 1.8 mH, Starting $T_{_{J}}$ = 25°C		250	
$V_{cc}$ = 50 V, $V_{ge}$ = 5.0 V, $P_{k} I_{L}$ = 14.9 A, $R_{g}$ = 1000 $\Omega$ , L = 1.8 mH, Starting $T_{J}$ = 150°C	E <sub>AS</sub>	200	mJ
$V_{cc} = 50 \text{ V}, V_{GE} = 5.0 \text{ V}, P_k I_L = 14.1 \text{ A}, R_G = 1000 \Omega, L = 1.8 \text{ mH}, \text{ Starting } T_J = 175^{\circ}\text{C}$		180	
Reverse Avalanche Energy			
$V_{cc}$ = 100 V, $V_{gE}$ = 20 V, $P_{k} I_{L}$ = 25.8 A, L = 6.0 mH, Starting $T_{J}$ = 25°C	E <sub>AS (R)</sub>	2000	mJ

## **Thermal Characteristics**

	Symbol	Value	Unit
Thermal Resistance, Junction to Case	R <sub>ejc</sub>	1.2	2000/
Thermal Resistance, Junction to Ambient DPAK (Note 1)	R <sub>eja</sub>	95	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	TL	275	°C

1. When surface mounted to an FR4 board using the minimum recommended pad size.



## **Electrical Characteristics - OFF**

Characteristic	Symbol	Test Conditions	Temperature	Min	Тур	Max	Unit						
Collector-Emitter		I <sub>c</sub> = 2.0 mA	T <sub>J</sub> = −40°C to 175°C	325	350	375							
Clamp Voltage	BV <sub>CES</sub>	l <sub>c</sub> = 10 mA	T <sub>J</sub> = −40°C to 175°C	340	365	390	V						
		V <sub>CE</sub> = 15 V V <sub>GE</sub> = 0 V	T <sub>J</sub> = 25°C	_	0.1	1.0							
Zero Gate Voltage			T <sub>J</sub> = 25°C	0.5	1.5	10							
Collector Current	CES	V <sub>ce</sub> = 175 V V <sub>ge</sub> = 0 V	T <sub>J</sub> = 175°C	1.0	25	100*	μΑ						
			$T_{J} = -40^{\circ}C$	0.4	0.8	5.0							
			T <sub>_</sub> = 25°C	30	35	39							
Reverse Collector–Emitter Clamp Voltage		$BV_{CES(R)}$	$BV_{CES(R)}$	$BV_{CES(R)}$	$BV_{CES(R)}$	$BV_{CES(R)}$	BV <sub>CES(R)</sub>	l <sub>c</sub> = -75 mA	T <sub>J</sub> = 175°C	35	39	45*	V
			T_= −40°C	30	33	37							
			T <sub>J</sub> = 25°C	0.05	0.25	1.0							
Reverse Collector-Emitter Leakage Current	I <sub>CES(R)</sub>	$V_{CE} = -24 V$	T <sub>J</sub> = 175°C	1.0	12.5	25	mA						
			$T_{J} = -40^{\circ}C$	-	0.03	0.25							
Gate-Emitter Clamp Voltage	BV <sub>GES</sub>	I <sub>g</sub> = ± 5.0 mA	T <sub>J</sub> = −40°C to 175°C	12	12.5	14	V						
Gate-Emitter Leakage Current	I <sub>GES</sub>	$V_{GE} = \pm 5.0 V$	T <sub>J</sub> = -40°C to 175°C	200	300	350*	μA						
Gate Resistor	R <sub>G</sub>	-	T <sub>J</sub> = -40°C to 175°C	-	70	-	Ω						
Gate-Emitter Resistor	R <sub>ge</sub>	_	T <sub>J</sub> = −40°C to 150°C	14.25	16	25	kΩ						

\*Maximum Value of Characteristic across Temperature Range.

3. Pulse Test: Pulse Width  $\leq$  300 µS, Duty Cycle  $\leq$  2%.



## Electrical Characteristics - ON (Note 4)

Characteristic	Symbol	Test Conditions	Temperature	Min	Тур	Max	Unit
			T_ = 25°C	1.5	1.8	2.1	
Gate Threshold Voltage	V <sub>GE (th)</sub>	$I_c = 1.0 \text{ mA},$ $V_{GE} = V_{CE}$	T <sub>J</sub> = 175°C	0.7	1.0	1.3	V
		GE CE	$T_{J} = -40^{\circ}C$	1.7	2.0	2.3*	
Threshold Temperature Coefficient (Negative)	-	_	_	3.8	4.6	6.0	mV/∘C
			T <sub>J</sub> = 25°C	0.95	1.15	1.35	
		$I_{c} = 6.5 \text{ A},$	T <sub>J</sub> = 175°C	0.7	0.95	1.15	
		$V_{ge} = 3.7 V$	T_ = -40°C	1.0	1.3	1.40	
			T <sub>J</sub> = 25°C	0.95	1.25	1.45	
		$I_{c} = 9.0 \text{ A},$	T_ = 175°C	0.8	1.05	1.25	
		V <sub>GE</sub> = 3.9 V	T_= −40°C	1.1	1.4	1.5	
		l <sub>c</sub> = 7.5 A,	T <sub>J</sub> = 25°C	0.85	1.15	1.4	
		Ŭ	T <sub>J</sub> = 175°C	0.7	0.95	1.2	
Collector-to-Emitter	N	$V_{GE} = 4.5 V$	$T_{J} = -40^{\circ}C$	1.0	1.3	1.6*	V
On-Voltage	V <sub>CE (on)</sub>	L = 10 A	T <sub>J</sub> = 25°C	1.0	1.3	1.6	V
		$I_{c} = 10 \text{ A},$	T <sub>J</sub> = 175°C	0.8	1.05	1.4	
		$V_{ge} = 4.5 V$	T_= -40°C	1.1	1.4	1.7*	
		15.0	T <sub>J</sub> = 25°C	1.15	1.45	1.7	
		$I_{c} = 15 \text{ A},$	T <sub>J</sub> = 175°C	1.0	1.3	1.55	
		$V_{GE} = 4.5 V$	T_= -40°C	1.25	1.55	1.8*	
			T <sub>J</sub> = 25°C	1.3	1.6	1.9	
			T <sub>_</sub> = 175°C	1.2	1.5	1.8	
		$V_{ge} = 4.5 V$	T_= -40°C	1.4	1.75	2.0*	
Forward Transconductance	gfs	I <sub>c</sub> = 6.0 A, V <sub>cE</sub> = 5.0 V	T <sub>J</sub> = 25°C	10	18	25	Mhos

\*Maximum Value of Characteristic across Temperature Range.

4. Pulse Test: Pulse Width  $\leq$  300 µS, Duty Cycle  $\leq$  2%.



## **Dynamic Characteristics**

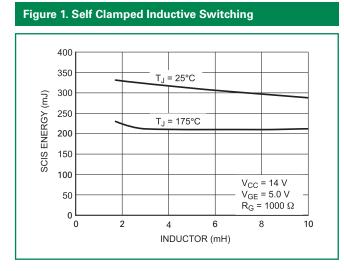
Characteristic	Symbol	Test Conditions	Temperature	Min	Тур	Max	Unit	
Input Capacitance	C <sub>ISS</sub>	V <sub>ce</sub> = 25 V f = 10 kHz			1100	1300	1500	
Output Capacitance	C <sub>oss</sub>			T <sub>J</sub> = 25°C	70	80	90	pF
Transfer Capacitance	C <sub>RSS</sub>			18	20	22		

## **Switching Characteristics**

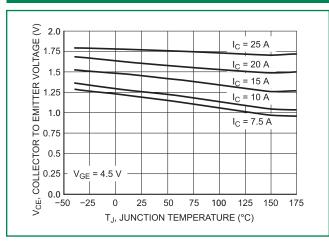
Characteristic	Symbol	Test Conditions	Temperature	Min	Тур	Max	Unit	
Turn–Off Delay Time		V <sub>cc</sub> = 300 V	T <sub>J</sub> = 25°C	6.0	8.0	10		
(Resistive)	t <sub>d (off)</sub>	$I_{c} = 9.0 \text{ A}$	T <sub>J</sub> = 175°C	6.0	8.0	10		
Fall Time	-	$R_{_{G}}$ = 1.0 kΩ $R_{_{L}}$ = 33 Ω	T <sub>J</sub> = 25°C	4.0	6.0	8.0		
(Resistive)	t <sub>f</sub>	$V_{\rm GE} = 5.0$ V	T <sub>J</sub> = 175°C	8.0	10.5	14		
Turn–Off Delay Time	t <sub>d (off)</sub>		T <sub>J</sub> = 25°C	3.0	5.0	7.0		
(Inductive)		V <sub>cc</sub> = 300 V I <sub>c</sub> = 9.0 A	T <sub>J</sub> = 175°C	5.0	7.0	9.0	0	
Fall Time		R <sub>g</sub> = 1.0 kΩ L = 300 μH	T <sub>J</sub> = 25°C	1.5	3.0	4.5	µSec	
(Inductive)	t <sub>f</sub>	$V_{GE} = 5.0 V$	T <sub>J</sub> = 175°C	5.0	7.0	10		
	1	V <sub>cc</sub> = 14 V	T <sub>J</sub> = 25°C	1.0	1.5	2.0		
Turn–On Delay Time	t <sub>d (on)</sub>	I <sub>c</sub> = 9.0 A	T_ = 175°C	1.0	1.5	2.0		
	$R_{L} = 1.5$	R <sub>L</sub> = 1.5 Ω	$R_{_{ m G}}$ = 1.0 kΩ $R_{_{ m L}}$ = 1.5 Ω	T <sub>J</sub> = 25°C	4.0	6.0	8.0	
Kise Time		$V_{ge} = 5.0 V$	T <sub>J</sub> = 175°C	3.0	5.0	7.0		



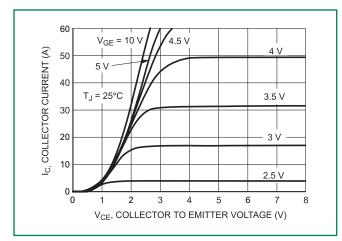
#### **Typical Electrical Characteristics**

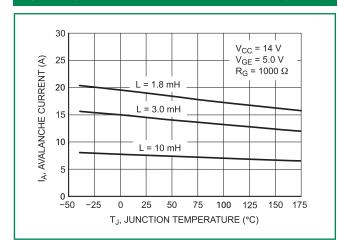


#### Figure 3. Collector-to-Emitter Voltage vs. Junction Temprature

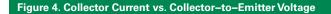


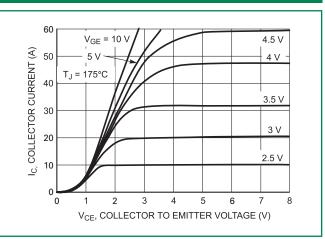
#### Figure 5. Collector Current vs. Collector-to-Emitter Voltage



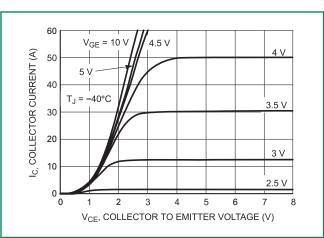


#### Figure 2. Open Secondary Avalanche Current vs. Temperature



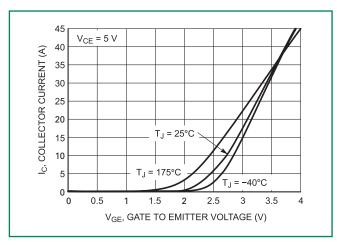


#### Figure 6. Collector Current vs. Collector-to-Emitter Voltage





## Figure 7. Transfer Characteristics



## Figure 9. Gate Threshold Voltage vs. Temperature

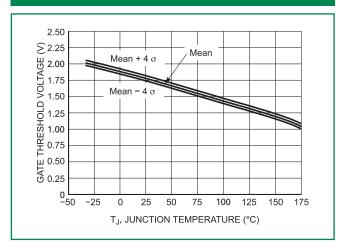
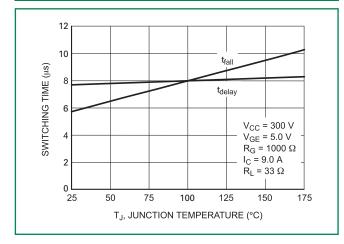
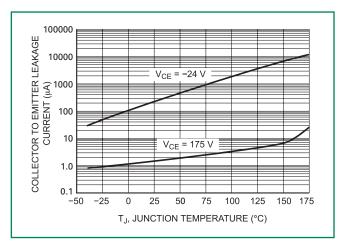


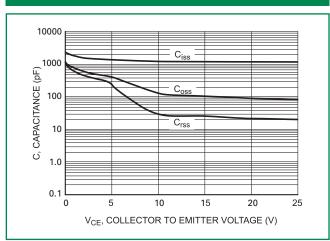
Figure 11. Typical Open Secondary Latch Current vs Temperature



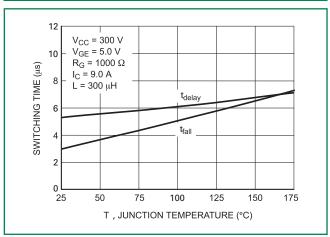
#### Figure 8. Collector-to-Emitter Leakage Current vs. Temperature



## Figure 10. Capacitance vs. Collector-to-Emitter Voltage



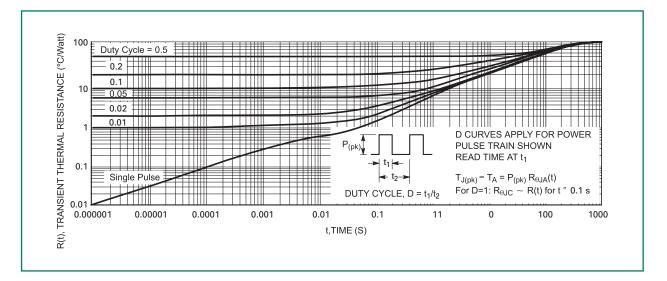
#### Figure 12. Inductive Switching Fall Time vs. Temperature



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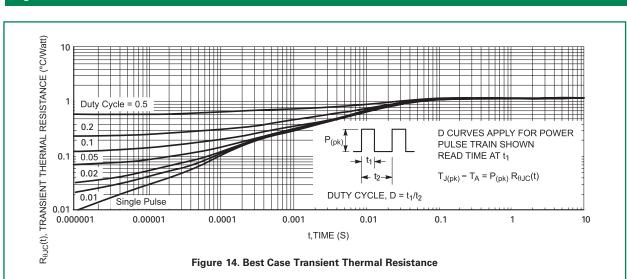


Figure 14. Best Case Transient Thermal Resistance (Non-normalized Junction-to-Case Mounted on Cold Plate)

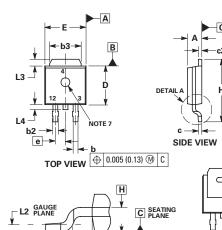


#### Dimensions

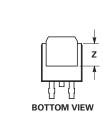
← L→

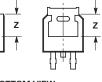
- L1

DETAIL A ROTATED 90° CW



A1





BOTTOM VIEW ALTERNATE

Dim	Inc	Inches		neters
Dim	Min	Max	Min	Max
А	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
с	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	) BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114	REF	2.90 REF	
L2	0.020	) BSC	0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

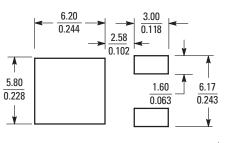
#### NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASMEY14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCH.
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

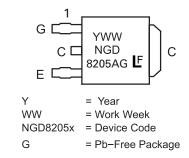
6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

## **Soldering Footrpint**



 $\left(\frac{mm}{inches}\right)$ SCALE 3:1

### **Part Marking System**



## **ORDERING INFORMATION**

Device	Package	Shipping†
NGD8205ANT4G	DPAK (Pb-Free)	2,500 / Tape & Reel

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